

# FDMS037N08B

## N-Channel PowerTrench® MOSFET

75 V, 100 A, 3.7 mΩ

### Features

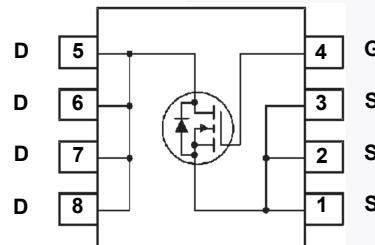
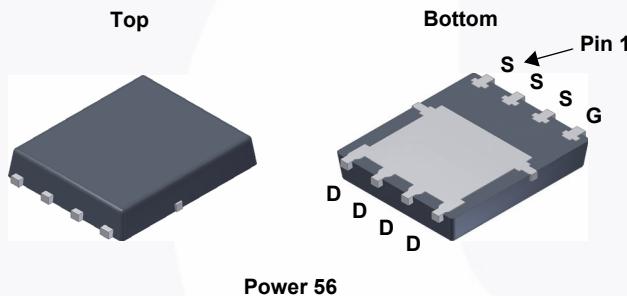
- $R_{DS(on)} = 3.01 \text{ mΩ}$  (Typ.) @  $V_{GS} = 10 \text{ V}$ ,  $I_D = 50 \text{ A}$
- Low FOM  $R_{DS(on)} * Q_G$
- Low Reverse Recovery Charge,  $Q_{rr} = 80 \text{ nC}$
- Soft Reverse Recovery Body Diode
- Enables Highly Efficiency in Synchronous Rectification
- Fast Switching Speed
- 100% UIL Tested
- RoHS Compliant

### Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advance PowerTrench® process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

### Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection circuit
- DC Motor Drives and Uninterruptible Power Supplies



### MOSFET Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted.

Symbol	Parameter		FDMS037N08B	Unit
$V_{DSS}$	Drain to Source Voltage		75	V
$V_{GSS}$	Gate to Source Voltage		$\pm 20$	V
$I_D$	Drain Current	- Continuous ( $T_C = 25^\circ\text{C}$ )	100	A
		- Continuous ( $T_C = 25^\circ\text{C}$ , Silicon Limited)	128	
		- Continuous ( $T_A = 25^\circ\text{C}$ ) (Note 1a)	19.9	
$I_{DM}$	Drain Current	- Pulsed (Note 2)	400	A
$E_{AS}$	Single Pulsed Avalanche Energy (Note 3)		180.6	mJ
$P_D$	Power Dissipation	( $T_C = 25^\circ\text{C}$ )	104.2	W
		( $T_A = 25^\circ\text{C}$ ) (Note 1a)	0.83	W
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to +150	°C

### Thermal Characteristics

Symbol	Parameter	FDMS037N08B	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. (Note 1a)	50	

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS037N08B	FDMS037N08B	Power 56	13 "	12 mm	3000 units

## Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
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### Off Characteristics

$\text{BV}_{\text{DSS}}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{ V}$	75	-	-	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$	-	39	-	$\text{mV}/^\circ\text{C}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	$\mu\text{A}$
$I_{\text{GSS}}$	Gate to Body Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	$\pm 100$	nA

### On Characteristics

$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$	2.5	-	4.5	V
$R_{DS(\text{on})}$	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$	-	3.01	3.7	$\text{m}\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_D = 50 \text{ A}$	-	108	-	S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 37.5 \text{ V}, V_{GS} = 0 \text{ V}$ $f = 1 \text{ MHz}$	-	4550	5915	pF
$C_{oss}$	Output Capacitance		-	1060	1380	pF
$C_{rss}$	Reverse Transfer Capacitance		-	30.2	45	pF
$C_{oss(er)}$	Energy Related Output Capacitance	$V_{DS} = 37.5 \text{ V}, V_{GS} = 0 \text{ V}$	-	1702	-	pF
$Q_{g(\text{tot})}$	Total Gate Charge at 10V		-	76.8	100	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{DS} = 37.5 \text{ V}, I_D = 50 \text{ A}$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$	-	27.5	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge		-	17.4	-	nC
$V_{\text{plateau}}$	Gate Plateau Volatge		(Note 4)	5.1	-	V
$Q_{\text{sync}}$	Total Gate Charge Sync.	$V_{DS} = 0 \text{ V}, I_D = 50 \text{ A}$	-	66.3	-	nC
$Q_{oss}$	Output Charge	$V_{DS} = 37.5 \text{ V}, V_{GS} = 0 \text{ V}$	-	74.6	-	nC
ESR	Equivalent Series Resistance	$f = 1 \text{ MHz}$	-	1.28	-	$\Omega$

### Switching Characteristics

$t_{d(\text{on})}$	Turn-On Delay Time	$V_{DD} = 37.5 \text{ V}, I_D = 50 \text{ A}$ $V_{GS} = 10 \text{ V}, R_G = 4.7 \Omega$	-	34.9	80	ns
$t_r$	Turn-On Rise Time		-	20.1	50	ns
$t_{d(\text{off})}$	Turn-Off Delay Time		-	55.3	120	ns
$t_f$	Turn-Off Fall Time		(Note 4)	19.4	49	ns

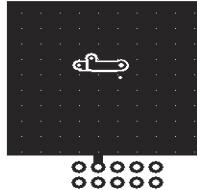
### Drain-Source Diode Characteristics

$I_S$	Maximum Continuous Drain to Source Diode Forward Current	-	-	100	A	
$I_{SM}$	Maximum Pulsed Drain to Source Diode Forward Current	-	-	400	A	
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{SD} = 50 \text{ A}$	-	-	1.3	V
$t_{rr}$	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{SD} = 50 \text{ A}$	-	66.8	-	ns
$Q_{rr}$	Reverse Recovery Charge	$dI_F/dt = 100 \text{ A}/\mu\text{s}$	-	84	-	nC

Notes:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.

a. 50 °C/W when mounted on a  
1 in<sup>2</sup> pad of 2 oz copper.



b. 125 °C/W when mounted on a  
minimum pad of 2 oz copper.



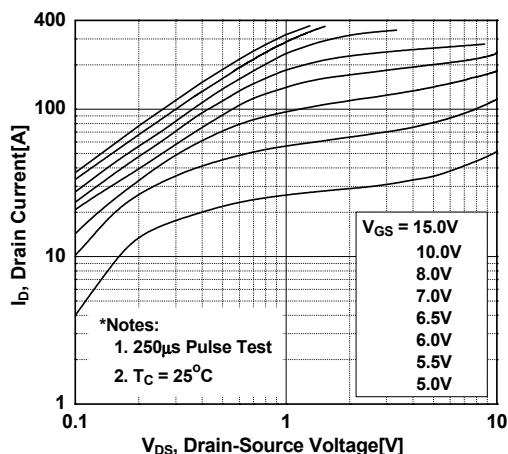
2. Repetitive rating: pulse-width limited by maximum junction temperature.

3. L = 0.3 mH,  $I_{AS} = 34.7 \text{ A}$ , starting  $T_J = 25^\circ\text{C}$ .

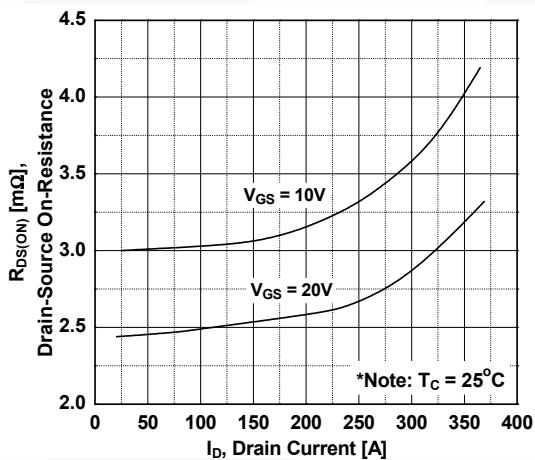
4. Essentially independent of operating temperature typical characteristics.

## Typical Performance Characteristics

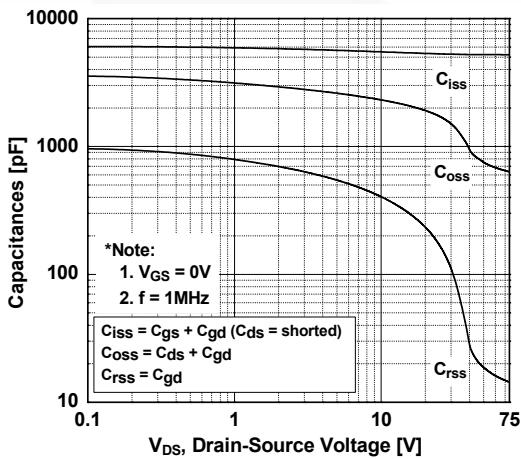
**Figure 1. On-Region Characteristics**



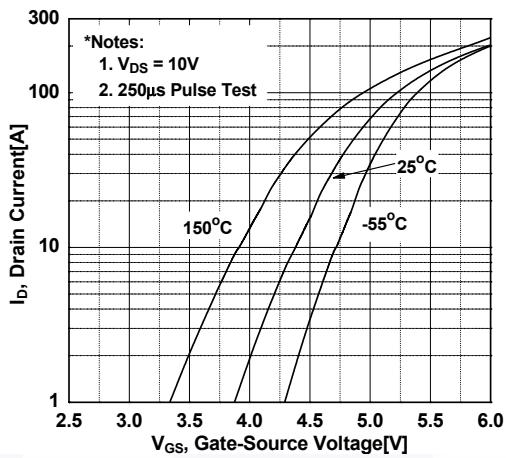
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



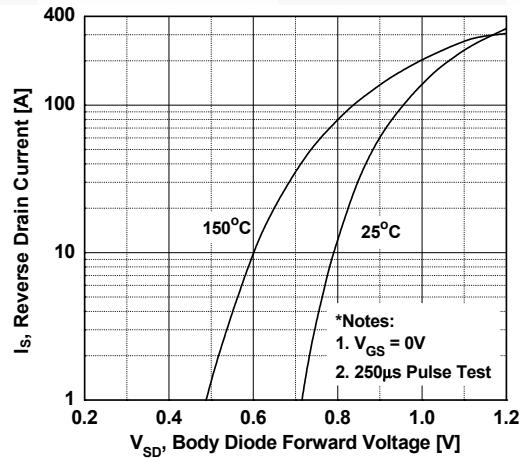
**Figure 5. Capacitance Characteristics**



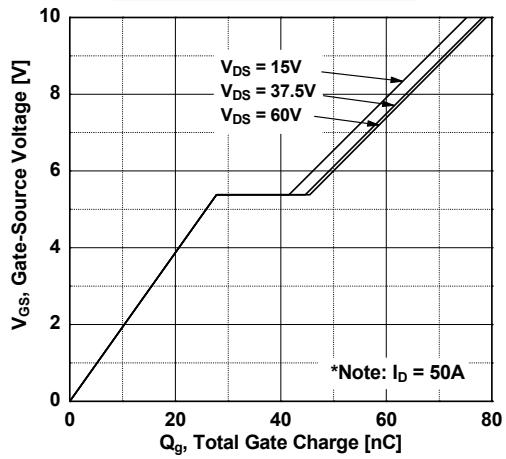
**Figure 2. Transfer Characteristics**



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

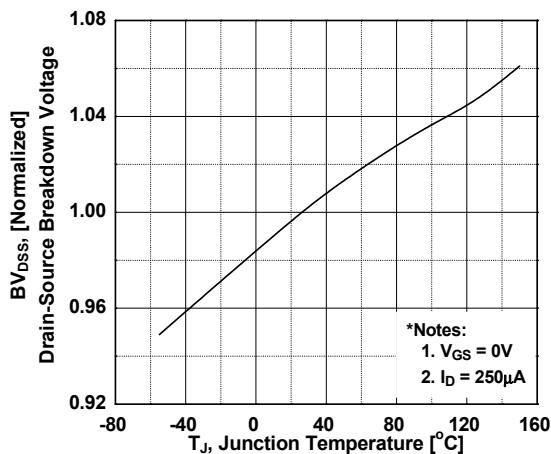


**Figure 6. Gate Charge Characteristics**

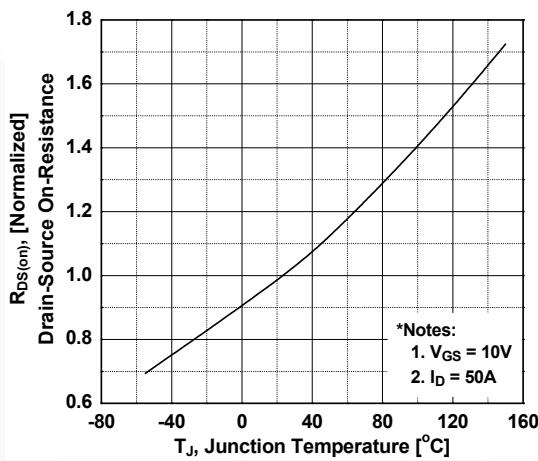


## Typical Performance Characteristics (Continued)

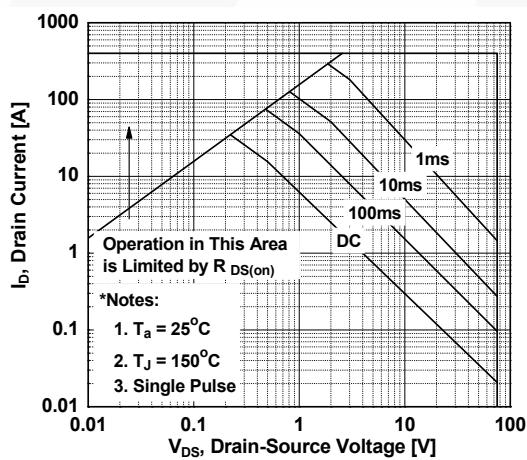
**Figure 7. Breakdown Voltage Variation vs. Temperature**



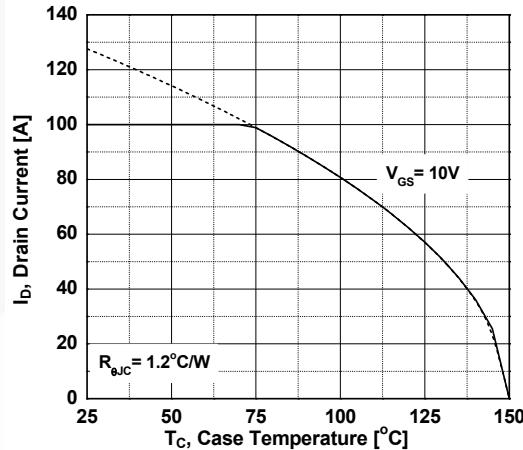
**Figure 8. On-Resistance Variation vs. Temperature**



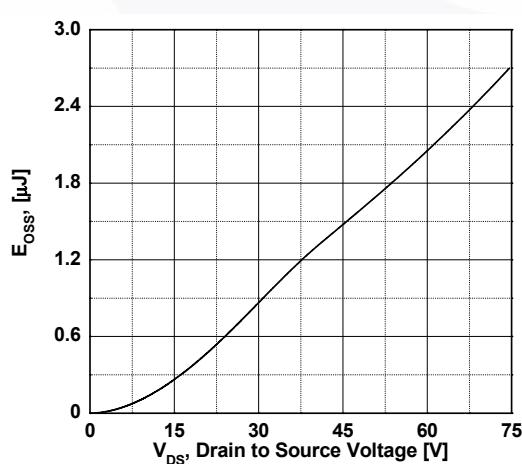
**Figure 9. Maximum Safe Operating Area**



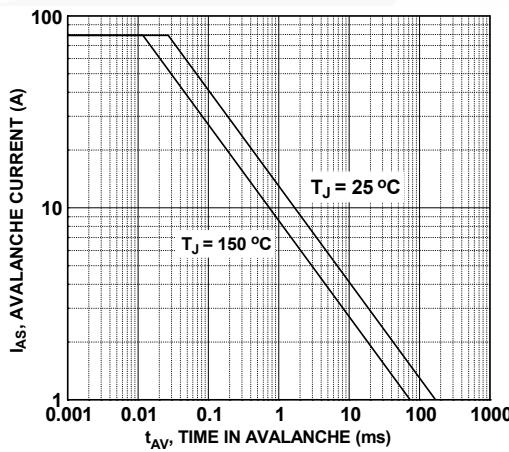
**Figure 10. Maximum Drain Current vs. Case Temperature**



**Figure 11. Eoss vs. Drain to Source Voltage**

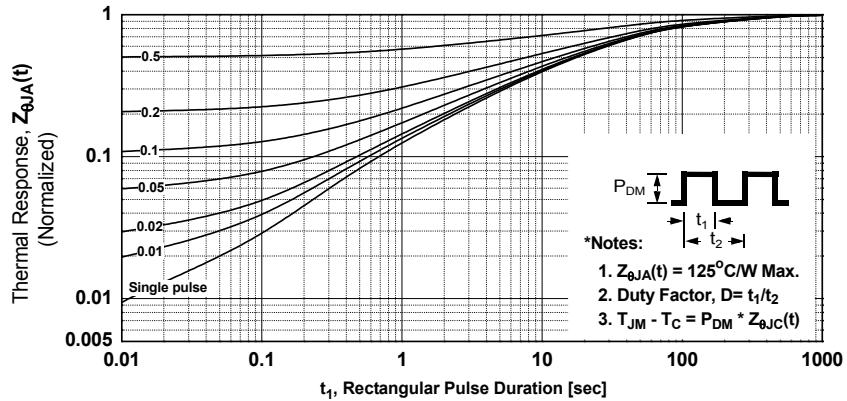


**Figure 12. Unclamped Inductive Switching Capability**

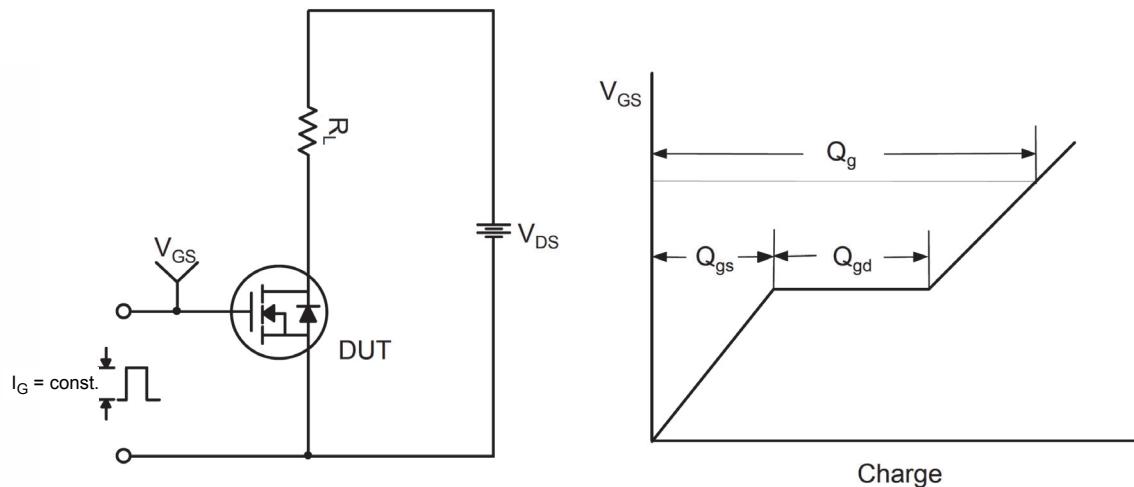


## Typical Performance Characteristics (Continued)

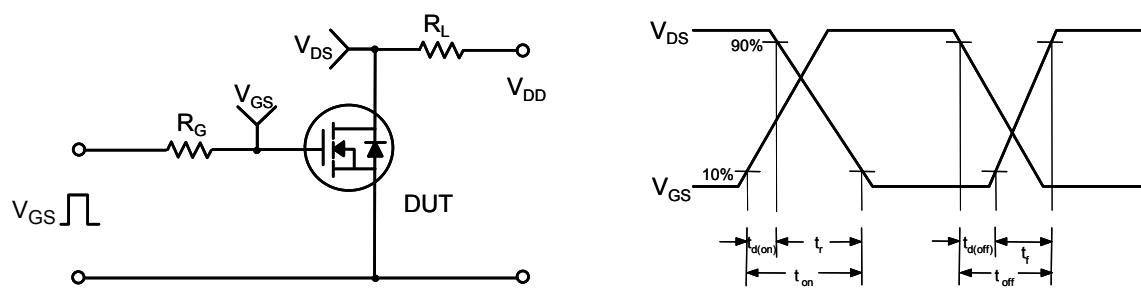
Figure 13. Transient Thermal Response Curve



**Figure 14. Gate Charge Test Circuit & Waveform**



**Figure 15. Resistive Switching Test Circuit & Waveforms**



**Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms**

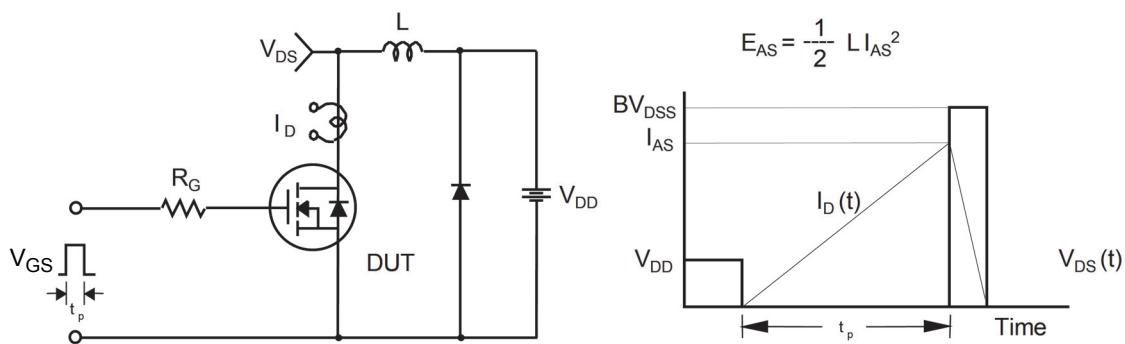


Figure 17. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms

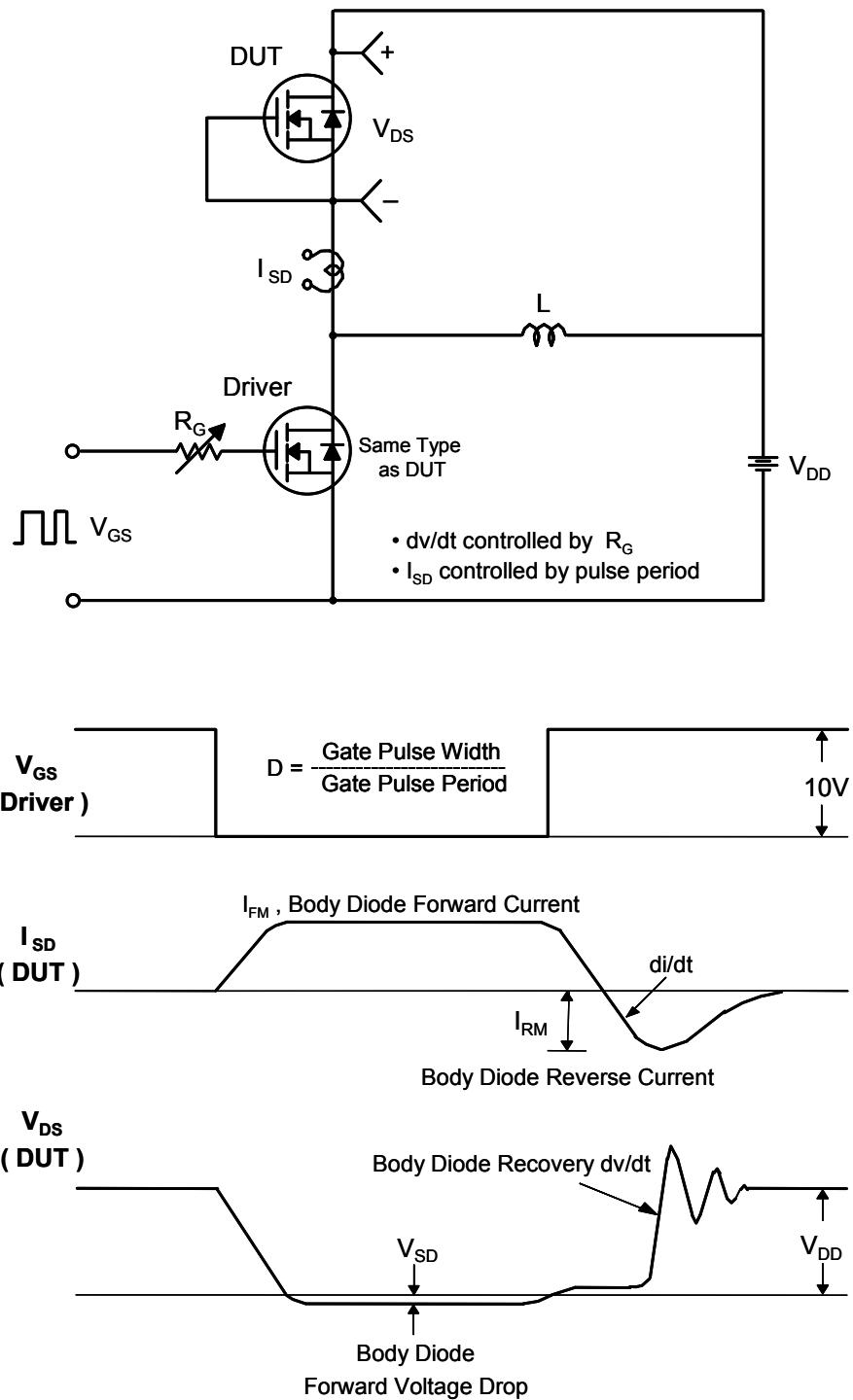
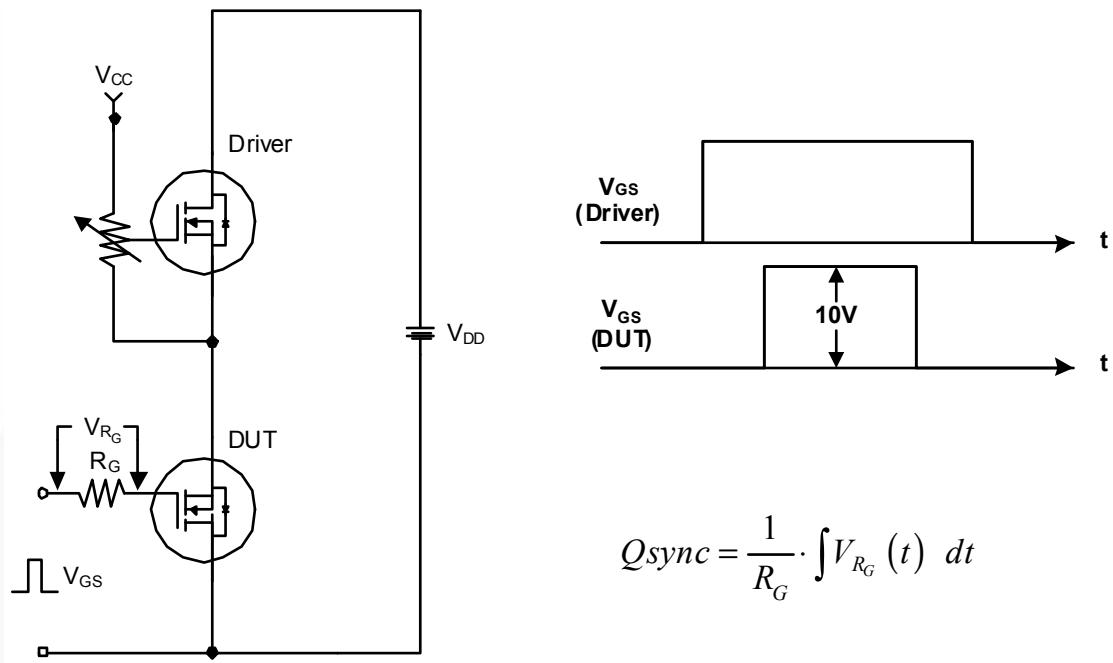


Figure 18. Total Gate Charge Qsync. Test Circuit & Waveforms



## Mechanical Dimensions

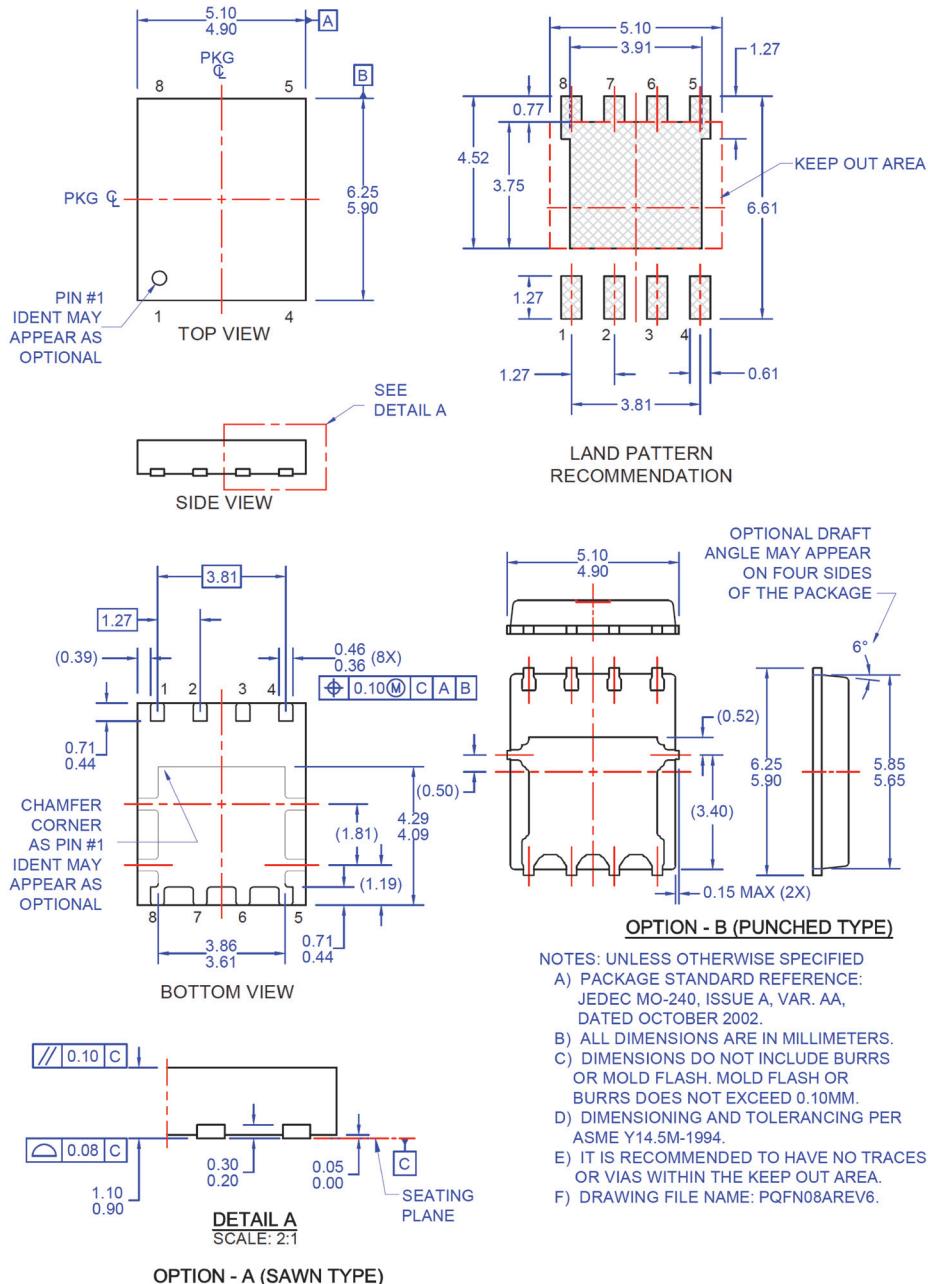


Figure 19. 8LD, PQFN, JEDEC MO-240 AA, 5.0X6.0MM

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